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Application/Control No.	Applicant(s)/Patent under Reexamination
10/502,389	ITO ET AL.
Examiner	Art Unit
Nacia N. Mar Buka	2405

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Class	Subclass	Date	Examiner
700	95-97, 117-121	3/13/2006	MNVB
705	7-10,26	3/13/2006	MNVB
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
PALM inventor search for double patenting	3/13/2006	MNVB			
EAST search (USPAT, USPGPUBs, EPO, JPO, Derwent & IBMTDBs files) - see notes	3/13/2006	MNVB			
PLUS search - see notes	3/13/2006	MNVB			
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